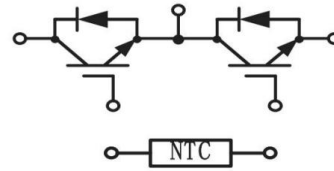


PRODUCT FEATURES

- IGBT CHIP(Trench+FS)
- Low saturation voltage and positive temperature coefficient
- Fast switching and short tail current
- Free wheeling diodes with fast and soft reverse recovery
- Temperature sense included
- 10 μ s Short Circuit Withstand


APPLICATIONS

- Motor Drives
- Power Charging Equipment
- Solar Power
- Electric Vehicle


IGBT

 ABSOLUTE MAXIMUM RATINGS($T_C = 25^\circ C$ unless otherwise specified)

Symbol	Parameter/ Test Conditions	Values	Unit
V_{CES}	Collector Emitter Voltage	1200	V
V_{GES}	Gate Emitter Voltage	± 20	
I_C	DC Collector Current	$T_C = 100^\circ C, T_{Jmax} = 175^\circ C$	A
I_{CM}	Repetitive Peak Collector Current	$t_p = 1\text{ ms}$	
P_{tot}	Power Dissipation Per IGBT	$T_C = 25^\circ C, T_{Jmax} = 175^\circ C$	kW

Diode

 ABSOLUTE MAXIMUM RATINGS($T_C = 25^\circ C$ unless otherwise specified)

Symbol	Parameter/ Test Conditions	Values	Unit
V_{RRM}	Repetitive Reverse Voltage	1200	V
$I_{F(AV)}$	Average Forward Current	400	A
I_{FRM}	Repetitive Peak Forward Current	$t_p = 1\text{ ms}$	
I^2t		$T_J = 150^\circ C, t = 10\text{ms}, V_R = 0V$	kA^2s

MODULE CHARACTERISTICS($T_C = 25^\circ C$ unless otherwise specified)

Symbol	Parameter/ Test Conditions	Values	Unit
T_{Jmax}	Max. Junction Temperature	175	$^\circ C$
T_{Jop}	Operating Temperature	-40~150	
T_{stg}	Storage Temperature	-40~125	
V_{isol}	Isolation Breakdown Voltage	AC, 50Hz(R.M.S), $t = 1\text{ minute}$	V
CTI	Comparative Tracking Index	> 200	
Torque	to heatsink	Recommended (M5)	3~5 Nm
	to terminal	Recommended (M6)	3~5 Nm
Weight		340	g

IGBT

 ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/ Test Conditions		Min.	Typ.	Max.	Unit	
$V_{GE(th)}$	Gate Emitter Threshold Voltage	$V_{CE}=V_{GE}, I_C=6\text{mA}$	5.4	5.9	6.5	V	
$V_{CE(sat)}$	Collector Emitter Saturation Voltage	$I_C=400\text{A}, V_{GE}=15\text{V}, T_J=25^\circ\text{C}$		1.65	2		
		$I_C=400\text{A}, V_{GE}=15\text{V}, T_J=125^\circ\text{C}$		1.95	2.35		
		$I_C=400\text{A}, V_{GE}=15\text{V}, T_J=150^\circ\text{C}$		2	2.4		
I_{CES}	Collector Leakage Current	$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_J=25^\circ\text{C}$			1	mA	
		$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_J=150^\circ\text{C}$			10	mA	
I_{GES}	Gate Leakage Current	$V_{CE}=0\text{V}, V_{GE}=\pm 20\text{V}, T_J=25^\circ\text{C}$			± 500	nA	
R_{gint}	Integrated Gate Resistor			1		Ω	
Q_g	Gate Charge	$V_{CE}=600\text{V}, I_C=400\text{A}, V_{GE}=15\text{V}$		4.6		μC	
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, V_{GE}=0\text{V}, f=1\text{MHz}$		62		nF	
C_{res}	Reverse Transfer Capacitance				0.82		pF
$t_{d(on)}$	Turn on Delay Time	$V_{CC}=600\text{V}, I_C=400\text{A}$ $R_G=1.5\Omega,$ $V_{GE}=\pm 15\text{V},$ Inductive Load	$T_J=25^\circ\text{C}$		220		ns
			$T_J=150^\circ\text{C}$		230		ns
t_r	Rise Time		$T_J=25^\circ\text{C}$		70		ns
			$T_J=150^\circ\text{C}$		80		ns
$t_{d(off)}$	Turn off Delay Time		$T_J=25^\circ\text{C}$		530		ns
			$T_J=150^\circ\text{C}$		600		ns
t_f	Fall Time		$T_J=25^\circ\text{C}$		260		ns
			$T_J=150^\circ\text{C}$		330		ns
E_{on}	Turn on Energy	$T_J=25^\circ\text{C}$		9		mJ	
		$T_J=150^\circ\text{C}$		15		mJ	
E_{off}	Turn off Energy	$T_J=25^\circ\text{C}$		55		mJ	
		$T_J=150^\circ\text{C}$		70		mJ	
I_{sc}	Short Circuit Current	$t_{psc}\leq 10\mu\text{S}, V_{GE}=15\text{V}$ $T_J=150^\circ\text{C}, V_{CC}=800\text{V}$		2300		A	
R_{thJC}	Junction to Case Thermal Resistance (Per IGBT)				0.052	K/W	

Diode-inverter

ELECTRICAL CHARACTERISTICS (T_C =25°C unless otherwise specified)

Symbol	Parameter/ Test Conditions	Min.	Typ.	Max.	Unit	
V _F	Collector Emitter Voltage	I _F =400A, V _{GE} =0V, T _J = 2 5 °C		1.65	2.05	V
		I _F =400A, V _{GE} =0V, T _J = 1 2 5 °C		1.75		
		I _F =400A, V _{GE} =0V, T _J = 1 5 0 °C		1.75		
T _{rr}	Gate Emitter Voltage		500		nS	
I _{RRM}	DC Collector Current	I _F =400A , V _R =600V di _F /dt=-4700A/μs T _J =150°C		365		A
Q _{RR}	Repetitive Peak Collector Current			90		μC
E _{rec}	Power Dissipation Per IGBT			27		mJ
R _{thJCD}	Junctionto CaseThermal Resistance (Per Diode)				0.086	kW

NTC CHARACTERISTICS (T_C=25°C unless otherwise specified)

Symbol	Parameter/ Test Conditions	Min.	Typ.	Max.	Unit
R ₂₅	Rated resistance	T _C = 2 5 °C	5		KΩ
ΔR/R	Deviation of R100	T _C = 100 °C, R ₁₀₀ =493Ω	-5	5	%
P ₂₅	Power dissipation	T _C = 2 5 °C		20	mW
B _{25/50}	B-value	R ₂ = R ₂₅ exp [B _{25/50} (1/T ₂ -1/(298.15 K))]	3375		K

IGBT Typical Performance

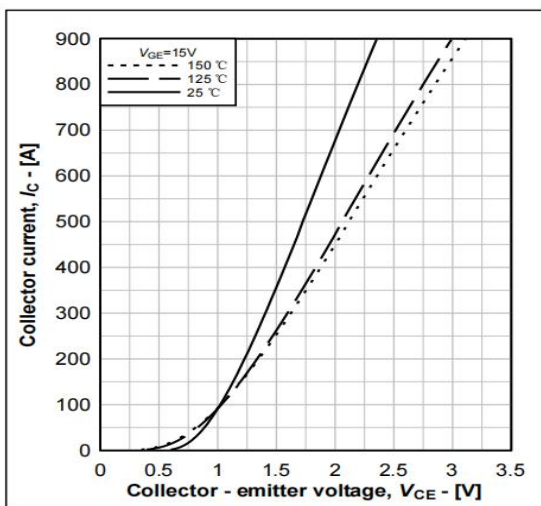


Figure1 Typical IGBT output characteristics

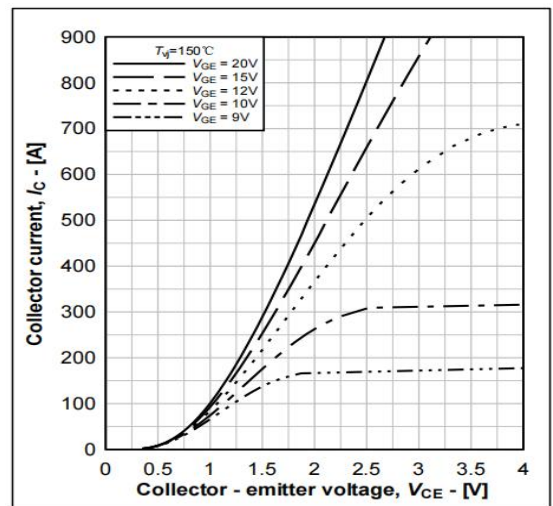


Figure2 Typical IGBT output characteristics

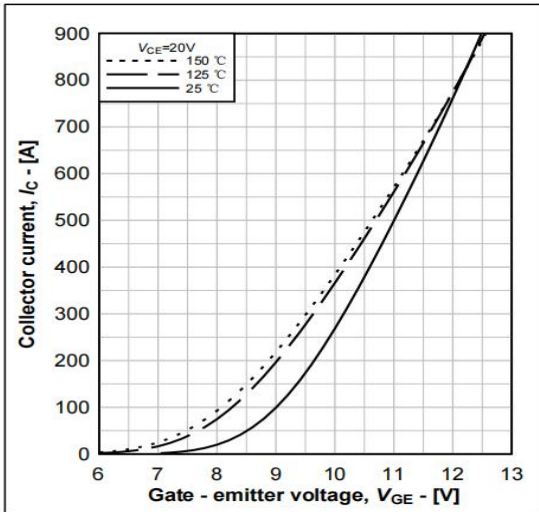


Figure3 Typical IGBT transfer characteristics

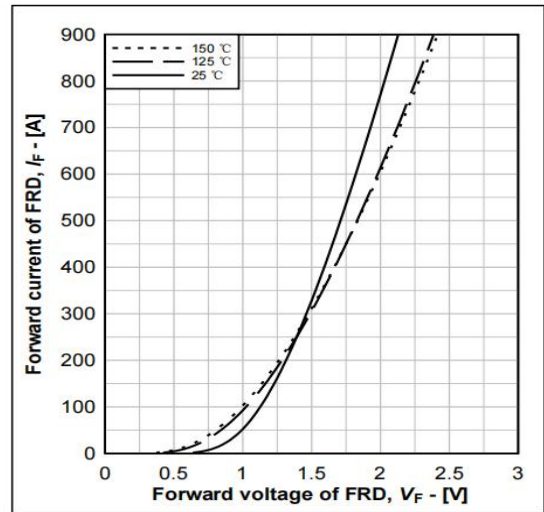


Figure4 Typical FRD output characteristics

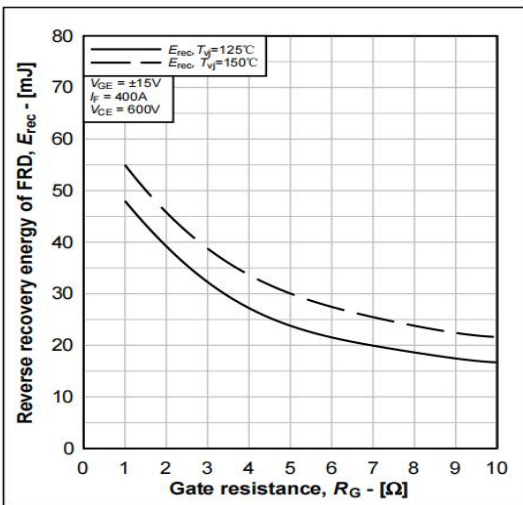


Figure5 Typical FRD Erec

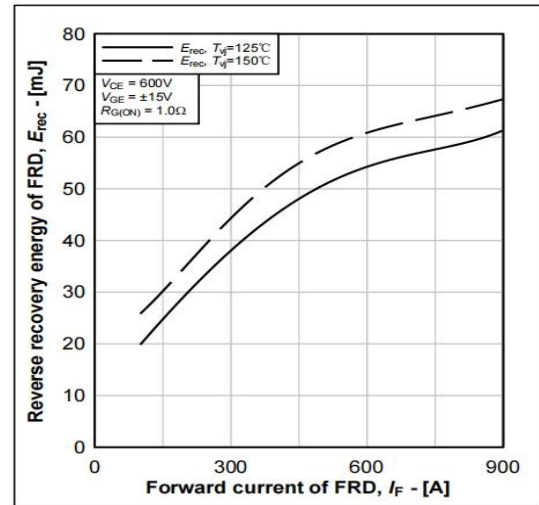


Figure6 Typical FRD Erec

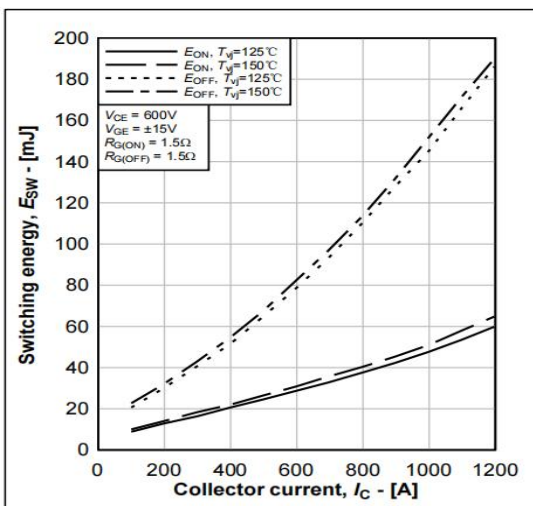


Figure7 Typical IGBT switching energy

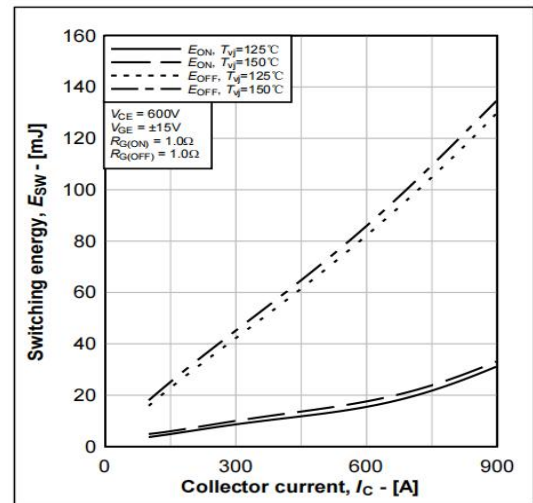


Figure8 Typical IGBT switching energy

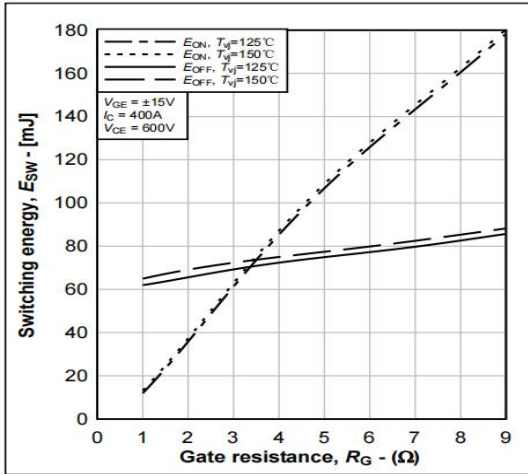


Figure9 Typical IGBT switching energy

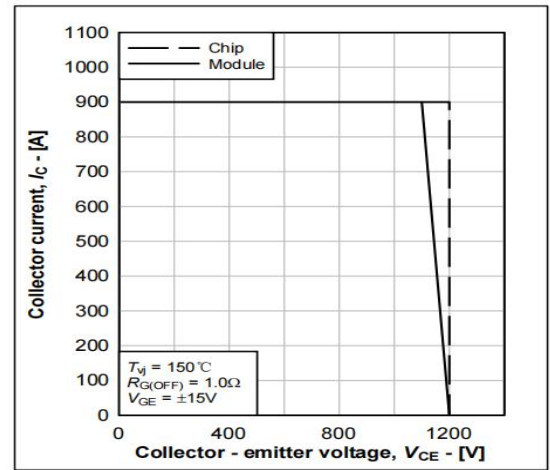


Figure10 Reverse bias safe operating area of IGBT

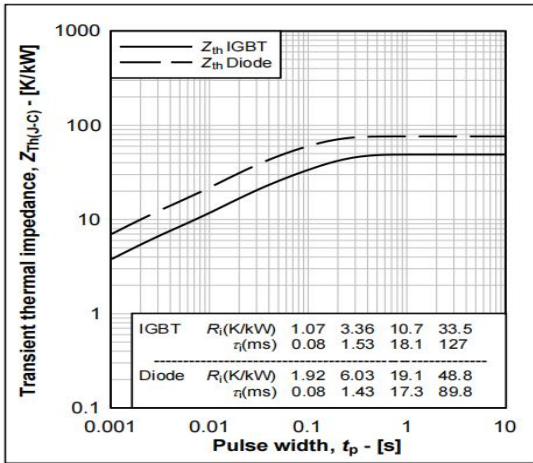


Figure11 Transient thermal impedance

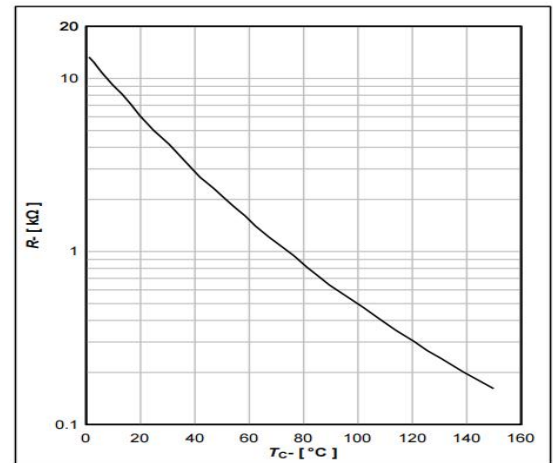
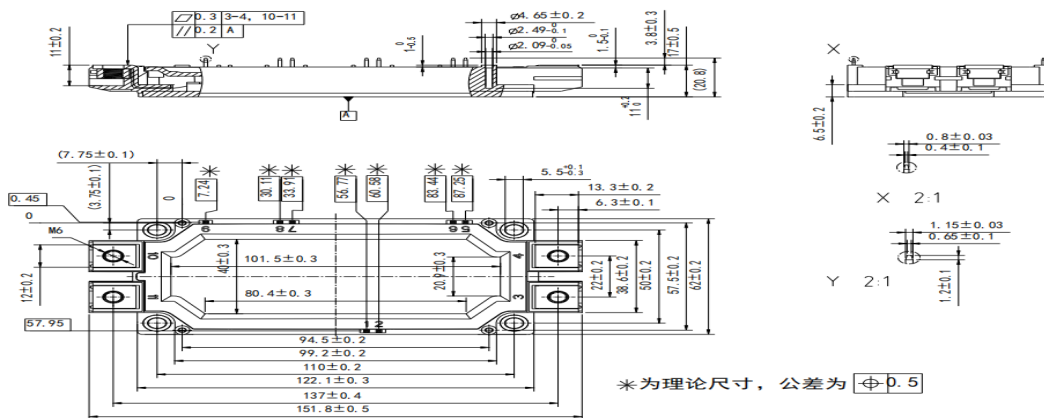


Figure12 Typical NTC thermistor characteristic

Package Dimensions: ED3



Dimensions in (mm)
Figure 11 Package Outline

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